

Nanodiamond Influence on the Nucleation and Growth of YBCO Superconducting Film Deposited by Metal–Organic Decomposition

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0 T). Such improvement appears to be due to the formation of denser and smoother films than the samples deposited without ND. This paper presents the work done to understand the role of ND during YBCO nucleation and growth. A detailed study on YBCO+ND films quenched at different temperatures of the crystallization process was carried out. Results showed that the reaction responsible for YBCO production appeared effectively affected by ND. In particular, ND stabilizes one of the YBCO precursors, $BaF_{2(1-x)}O_{xy}$ whose conversion into YBCO requires a prolonged time. Therefore, the YBCO nucleation is slowed down by ND and begins when the experimental conditions favor both thermodynamically and kinetically the



formation of YBCO along the *c*-axis. This effect has important implications because the growth of a highly epitaxial *c*-axis YBCO film enables excellent superconducting performance.

INTRODUCTION

The use of superconducting materials for power application was envisaged since their discovery in 1911.^{1,2} Penetration of the magnetic field above the lower critical field H_{c1} as flux quanta (fluxons) inside the superconductor and their resulting motion due to the Lorentz force, in the absence of defects able to pin them, produce dissipation and no critical current can be observed. Therefore, pinning fluxons is a crucial issue for the practical use of all superconducting materials. Intrinsic pinning due to lattice defects such as grain boundaries, impurities, dislocations, point defects, and so on are spontaneously generated during material processing.^{3,4} However, more effective pinning can be obtained through the introduction of the so-called artificial pinning centers (APCs). In this way, the controlled size and shape of APCs can be engineered, depending on the operation conditions in which the superconductor is designed to be used.^{3,5}

Rare-earth cuprate materials $REBa_2Cu_3O_{7-\delta}$ (*REBCO*, in which *RE* is Y or rare earth) are widely studied as epitaxial films for the production of superconducting tapes (coated conductors) for power applications. Two main routes are used for film deposition, namely, pulsed laser deposition (PLD) and metal–organic decomposition (MOD). While the former technique is well established and widely used for industrial production of *REBCO* tapes, the latter is considered very appealing due to the inexpensive setup, basically consisting of

the deposition of the precursor solution and a conversion heat treatment. However, while a high amount of defects are typically generated by means of the PLD technique, chemical solution deposition (CSD) of *REBCO* films by MOD leads to comparatively low-defect films showing poor intrinsic pinning. Therefore, APC introduction in MOD-derived *REBCO* films is necessary to increase their performances in order to be able to compete with PLD-grown films. The introduction of APCs in *REBCO* films by PLD is easily carried out by adding the desired second phase to the *REBCO* target (e.g., BaZrO₃, BaHfO₃, Ba₂YNbO₆, Ba₂YTaO₆).

The introduction of APCs in the *REBCO* matrix by MOD can be obtained according to two main approaches, i.e., adding either the precursor of the second phase (in situ) or preformed nanoparticles (NPs) (ex situ) to the *REBCO* precursor solution. The former approach is carried out by adding the desired precursor or an excess of one element, such as Y or Gd, to the precursor solution. Metal ions exceeding the 123 *REBCO* stoichiometry will form other phases.^{6–8} The latter approach

 Received:
 May 18, 2023

 Revised:
 June 25, 2023

 Published:
 July 15, 2023





includes the preparation of preformed NPs, which are dispersed in the precursor solution. The main advantage of using preformed NPs is the possibility of easily customizing the size and concentration of the precursor solution. Among the proposed NPs used as APCs, BaMO₃ (M = Zr, Hf, Sn) can be mentioned.^{9–11} Nanodiamond (ND) was proposed as an APC in metal-organic deposited YBCO films for the first time a few years ago.^{12,13} Detonation NDs are easily produced with a controlled size below 10 nm, suitable for zero-dimensional defect generation. Our first experiments showed that ND addition to YBCO solution positively affects both film morphology and superconducting properties. YBCO+ND films are generally more compact, smoother, and denser with higher critical current density, J_c . By I-V analyses, self-field J_c values (B = 0 T) of 4 and 18 MA·cm⁻² are obtained for YBCO +ND at 77 and 10 K, respectively, compared with J_c values of 2.3 \pm 0.9 and 13 \pm 1.2 MA·cm⁻² of pure YBCO. The higher J_c in self-field condition measured in YBCO+ND samples is likely due to a better grain coalescence and higher film density, which leads to an increase of the percolation paths in the film.

Moreover, the J_c (B, \overline{T}) curves for the set of samples demonstrated that ND has not a clear influence on vortex pinning, likely due to the ND concentration used in YBCO solution, namely, $\leq 5 \text{ mol }\%$, which is very low in comparison with NP concentration studied by other laboratories. In fact, the introduction of NPs such as BaMO₃, ZrO₂, and Ba₂YTaO₆, with concentrations in the range of 5–32 mol % produced a significant pinning increase. Besides, the effect on J_c in self-field condition is dependent on both the nature and concentration of NPs,^{9–11,14–19} although increased self-field J_c is observed only in a few studies.^{10,19}

Conversely, some articles reported that YBCO films prepared by MOD and using Au, Ag, and Pb as dopants showed an improvement in morphology along with higher self-field J_c values. In those cases, when a metallic dopant is used, the formation of intermetallic phases is likely responsible for chemical potential changes of *c*- and *a*-axis nucleations favoring the *c*-axis orientation.^{20–23} In analogy to such studies, it may be assumed that the addition of ND is beneficial to *c*-axis film nucleation during the crystallization step. However, in the case of carbon-based nanomaterials (CBNs), the intermetallic phase formation can be excluded, so a different mechanism (or influence) should be hypothesized.

Therefore, in the present paper, we report the results of experiments designed and performed with the aim of clarifying the role of ND in promoting YBCO nucleation and growth. The microstructural properties of YBCO films produced with or without ND and quenched at different steps of the thermal treatment were characterized, shedding light on the effect of ND on the reaction of YBCO formation. Based on the obtained results, an explanation of the improvement in film performances is provided.

EXPERIMENTAL SECTION

Materials. Ammonium hydroxide ultrapure solution (NH₄OH, MW 35.05 g·mol⁻¹, J.T. Baker, Ultrex, 20–22%), barium (II) trifluoroacetate hydrate (Ba(CF₃CO₂)₂·xH₂O, MW 363.37 g·mol⁻¹ (anhydrous basis), Alfa Aesar), copper (II) acetate (Cu(CO₂CH₃)₂, MW 181.63 g·mol⁻¹, Sigma-Aldrich, trace metals basis, 99.99%), methanol (CH₃OH, MW 32.04 g·mol⁻¹, Sigma-Aldrich, for HPLC gradient grade, \geq 99.9%), nanodiamond (ND) powder (produced by detonation from International Technology Center, ITC, with purity > 98% and 4–5 nm primary particle size), propionic acid (CH₃CH₂COOH, MW 74.08 g·mol⁻¹, Sigma-Aldrich, ACS reagent, ≥99.5%), yttrium (III) acetate hydrate ($Y(CH_3CO_2)_3$ ·xH₂O, MW 266.04 g·mol⁻¹ (anhydrous basis), Sigma-Aldrich, 99.9%), strontium titanate (SrTiO₃ (STO), (001) single crystals, size: 7.5 × 7.5 mm², Wollemi Technical Incorporation and MaTecK (Material Technologie & Kristalle GmbH)), silicon (100) wafer (NanoVision s.r.l. (Gambetti Kenologia)) were used.

Equipment. All labware used in the experiments was soaked in diluted HNO₃ overnight and then rinsed with ultrapure water. Ultrapure water (18.2 M Ω ·cm at 25 °C) was produced by the Synergy UV Remote system integrated with the Elix module, supplied by Millipore. Solution homogenization, substrate cleaning, and nanodiamond dispersion were carried out using Elmasonic S30H, Elma GmbH, and Sonica 2200, Soltec, ultrasonic baths. An ultrasonic homogenizer probe, Bandelin SONOPULS HD2200, was employed for colloidal dispersion preparation adopting the following conditions: 40% power, 20 min each run. A Rotavapor R-215 B.U.CHI was used as a rotary evaporator during YBCO precursor solution preparation. The precursor solution was deposited by spin coating using the spinner WS-400BZ-6NPP/LITE supplied by Laurell Corporation. For the thermal treatment, a homemade tube furnace with a furnace body length of 150 mm and a Eurotherm 2048 Temperature controller/programmer for the control of thermal cycles was used. A quartz tube with an inner diameter of 2.5 cm was employed. The furnace was coupled with gas flowmeters (300 VUE, Teledyne, Hastings Instruments) to regulate the atmosphere. Humid gases were obtained by bubbling the carrier gas through three Drechsel flasks partially filled with ultrapure water kept at 21 °C (corresponding to a saturated vapor partial pressure of 25 mbar).

Methods. YBCO Film Synthesis. Preparation of YBCO Precursor Solution. In a typical experiment, a pure YBCO low-fluorine solution, 0.2 M referred to as $[Y^{3+}]$, was prepared with yttrium (III) acetate hydrate (1 mmol), barium (II) trifluoroacetate hydrate (2 mmol), and copper (II) acetate (3.1 mmol). A small excess of copper acetate was used in consideration of the copper loss possibly occurring during the pyrolysis step.²⁴ Precursors' salts were separately dissolved in excess methanol (MeOH) in three different beakers employing an ultrasonic bath for 5 min. Then, exact volumes of propionic acid, with a total of 5 mL, were added to each solution that was further sonicated for 5 min. Finally, 0.5 mL of NH₄OH was added to the Cu solution to favor metal solubilization. At the end of this procedure, the salts appeared completely dissolved and the three solutions were merged in a single beaker and underwent another 10 min of sonication. Thereafter, the solution was quantitatively transferred in a round-bottom flask using MeOH for beaker cleaning. Then, a rotary evaporation process was performed at 58 °C/306 mbar and 75 °C/153 mbar to eliminate both MeOH and water content. The solution was transferred and stored in an amber vial in a flowing nitrogen desiccator.

Nanodiamond Colloidal Dispersion and YBCO+ND Precursor Solution. Detonation ND with 4–5 nm primary particle size diameter and 30 nm average agglomerate size was used for the preparation of the colloidal dispersion. ND, 6 mg accurately weighed, was dispersed in 20 mL of propionic acid using first an ultrasonic bath for 4 h. After overnight sedimentation, the supernatant was separated from the solid residue and treated with a more powerful sonicator (the ultrasonic homogenizer probe) at room temperature for 6 h.

At the end of the sonication treatment, the ≤ 10 nm size of nanoparticles in the dispersion was verified by scanning electron microscopy (SEM) and atomic force microscopy investigations performed on samples prepared by depositing $10 \ \mu L$ of ND dispersion on the Si wafer through spin coating (3000 rpm, 60 s) and drying for 15 min at 130 °C in air.

A rough estimation of ND concentration ≤ 0.01 M in the dispersion was calculated on the basis of the recovered precipitate.

The YBCO+ND precursor solution was prepared by modifying the usual procedure and replacing pure propionic acid with ND dispersion. The amount of C introduced in YBCO solution in the form of ND can be approximately considered to be $\leq 5 \mod \%$ with respect to Y³⁺ concentration.

YBCO Film Deposition. The precursor solution was spin-coated for 60 s at a spinning rate of 3000 rpm on the STO substrate. In standard conditions, films were pyrolyzed in a quartz tube furnace with flowing



Figure 1. Schematic representation of the pyrolysis and firing steps of the thermal treatment. The samples produced for studying the evolution of film composition are evidenced as colored dots.



Figure 2. SEM images at the same magnification of YBCO (a) and YBCO+ND (b) films deposited simultaneously during the same thermal treatment. The scale bar corresponds to $1 \mu m$.

oxygen (0.94 L·min⁻¹, humid for $T > 100 \,^{\circ}$ C) up to 480 $^{\circ}$ C using the following heating ramp rate: 10 $^{\circ}$ C·min⁻¹ (up to 90 $^{\circ}$ C), 2.5 $^{\circ}$ C·min⁻¹ (in the range of 90–200 $^{\circ}$ C), 1.2 $^{\circ}$ C·min⁻¹ (in the range of 200–300 $^{\circ}$ C), 10 $^{\circ}$ C·min⁻¹ (in the range of 300–480 $^{\circ}$ C), and 10 $^{\circ}$ C·min⁻¹ (during the cooling step).

A second treatment, named "firing", was then performed to promote YBCO crystallization and oxygenation. First, the sample was heated with a rate of 10 °C·min⁻¹ to the dwell temperature of 830 °C and kept for 50 min in a humid mixture of nitrogen and oxygen (flow rate N₂: $2.83 \text{ L}\cdot\text{min}^{-1}$, O₂: $1.15 \times 10^{-3} \text{ L}\cdot\text{min}^{-1}$) and further 10 min in the same dry mixture (crystallization step). Subsequently, the film was cooled down to 450 °C with a rate of 10 °C·min⁻¹, kept at this temperature for 15 min in dry oxygen (0.94 L·min⁻¹) for the oxygenation step and then cooled to room temperature with the same ramp rate. A final film thickness of 78 ± 3 nm was obtained.

Films Deposition for the Nucleation and Growth Study. YBCO +ND thin films were deposited on the STO substrate by spin coating, using the standard pyrolysis and firing conditions optimized for pure YBCO films. In order to clarify the influence of ND on YBCO nucleation, a specific experiment aimed at studying the structural and chemical evolution of propionate-based low-fluorine YBCO precursors during the conversion thermal treatment was carried out. In particular, a set of partially converted samples was prepared: one sample pyrolyzed at 480 °C, six samples quenched to different temperatures during the firing treatment (i.e., quenched at 550, 650, 750, 795, 830 °C and one sample treated at 830 °C for 30 min before quenching) and another one subjected to the complete thermal process necessary to promote full YBCO conversion. The same experiment was performed on both YBCO+ND and pure YBCO films. The latter ones were used as a reference. A final thickness of about 80 nm was obtained in all cases. A schematic representation of the thermal treatment and of the produced samples is reported in Figure 1. In our previous article,¹³ problems with YBCO+ND solution stability were observed despite the ND

concentration in YBCO solution being estimated to be very low, [ND] < 5 mol %. However, it was verified that samples prepared with fresh solution and within the same day show comparable properties. Therefore, the YBCO+ND samples necessary for the nucleation study were pyrolyzed on the same day with a precursor solution prepared no more than 12 h before.

Film Characterization. Morphology. Optical microscopy was employed to investigate film surface morphology after the thermal treatment. A Nikon SMZ18 stereomicroscope and a Leitz–Wetzlar Metalloplan metallographic microscope were used for this purpose.

SEM images were acquired by a Gemini LEO 1525 field emission high-resolution SEM with 10–20 kV accelerating voltages and an inlens high-resolution annular detector.

Structural Analysis. The X-ray diffraction (XRD) technique was employed for the structural properties and texture analyses of pure and composite YBCO films. A Rigaku Geigerflex diffractometer with Cu K α radiation in Bragg–Brentano configuration was used for the acquisition of X-ray θ – 2θ and ω -scans.

YBCO+ND films were also analyzed by transmission electron microscopy (TEM). For TEM investigations, a cross-sectional lamella was produced by a focused ion beam technique, employing an FEI Dual Beam Helios NanoLab system. The cross-sectional lamella was taken from the strips used for transport analyses in order to correlate the information gained from TEM with superconducting properties. The annular dark-field and high-angle annular dark-field scanning transmission electron microscopy (ADF and HAADF-STEM) imaging and energy-dispersive X-ray spectroscopy (EDX) were performed using an FEI Titan electron microscope, equipped with a Cs-aberration corrector for the probe-forming lens and a "Super-X" wide solid angle EDX detector operating at 200–300 kV acceleration voltages.^{25,26}

Superconducting Properties. The zero-resistance critical temperature, T_c , was assessed through R(T) measurements performed by d.c. electric measurements in the four-probe configuration with a 2420



Figure 3. (a) HAADF-STEM overview of the YBCO+ND film deposited by the standard process (taken along the [100]/[010]YBCO zone axis), (b) some outgrowths segregated at the surface, and (c) high density of twin boundaries (highlighted by yellow arrows).



Figure 4. HAADF-STEM view of areas with a high density of stacking faults, marked by red arrows and a dotted line, present at the surface (upper panel). The sharp interface between YBCO and STO is shown in the lower panel.



Figure 5. HAADF-STEM view of different areas of YBCO+ND film bulk. Short stacking faults are visible (partially hidden due to the sample thickness).



Figure 6. Cross-sectional view of the YBCO+ND film. The HAADF-STEM image showing the mapped area, evidenced by a green rectangle, together with elemental Y, Ba, Cu, O, C, Sr, and Ti EDX maps.

Keithley current source meter (used current 100 $\mu A)$ and a 2182 A Keithley nanovoltmeter.

RESULTS

The fully processed YBCO and YBCO+ND samples showed morphological, structural, and superconducting properties in line with our previously reported samples.¹³ In particular, the recorded XRD patterns showed only YBCO (00*l*) diffraction peaks and revealed the good *c*-axis-oriented grain structure in both pure YBCO and YBCO+ND films. As already reported,¹³ no significant differences were detected in the fully converted films as regards several parameters such as the full width at half-maximum (FWHM) calculated from (005) YBCO ω -scan, *c*-axis lattice parameter, and intensity ratio, i.e., similar crystallinity.

SEM analyses confirmed an improvement in film morphology when ND was added. In fact, pure YBCO showed several uncovered substrate regions, while the YBCO+ND film displayed only a few pores. Further, in the latter, a lower amount of sub-micrometric particulates occurred (Figure 2).

The effect on the YBCO structure due to ND addition was further investigated through the TEM analysis of the YBCO +ND film deposited using the standard thermal treatment. In Figure 3, the HAADF-STEM cross-sectional overview of the film on the STO substrate is shown. An ordered and dense YBCO structure was evident, along with a high density of twin boundaries (highlighted by yellow arrows in Figure 3c). The surface of the layer was decorated by several secondary phase particles.

The YBCO layer grows epitaxially on the STO substrate: $[010]STO//[100]/[010]YBCO \langle 001 \rangle STO//\langle 001 \rangle YBCO$. The interface with the substrate is very sharp and no nanoparticles or secondary phases could be distinguished (Figure 4). A large number of staking faults were observed at the outer surface, whereas this kind of defect was almost absent at the interface. Some misfit dislocations were observed on the



Figure 7. TEM cross-view of several regions evidencing the presence of unidentified defects.



Figure 8. XRD θ -2 θ patterns of partially converted YBCO samples: one sample pyrolyzed at 480 °C and six samples quenched after pyrolysis at different temperatures during the firing treatment. The curve named "830 °C + 30'" indicates a sample treated at 830 °C for 30 min before quenching. The pattern of a film subjected to the whole firing process and labeled as "full firing" is plotted for comparison. Vertical lines show the peak positions of BaF₂ (dashed line), Y₂Cu₂O₅ (dotted line), and CuO (continuous line). The labels of (111), (200), (220) BaF₂ and (004), (005) YBCO peaks are also reported. The asterisk (*) evidences a Y–Ti–O secondary phase due to the solution–substrate interaction.^{36,37} The symbol (\Diamond) marks the STO K_{β} peak.

STO-YBCO interface (lower panel of Figure 4). The film contains a number of short stacking faults (Figure 5). However, some secondary phases and outgrowths were observed. The STEM-EDX analysis provided information on the chemical composition of the film (Figure 6). The distribution of Y, Ba, Cu, and C in the whole analyzed zone is uniform, whereas at the surface, an accumulation of copper oxide is sometimes evident. No traces of ND particles were revealed, proving that they likely did not survive the thermal treatment.

The presence of several features at the interface is worth noticing, whose nature was not completely clarified by the EDX analysis but, most likely, these are holes (Figures 3b and 7). In particular, they were observed only at the interface and never embedded in the film matrix. The presence of this feature did not produce any increase of strain or other defects, e.g., stacking faults, in its surroundings as, on the contrary, revealed in films where other NPs are at the substrate interface and strain or stacking faults are evident in the film grown around the NP. $^{10,27-29}$

The superconducting properties of fully converted YBCO +ND film confirmed the good results previously emerged. A sharp superconducting transition was observed, with a T_c value as high as 90.7 K, in line with the mean value^{*a*} of 90.4 \pm 0.2 K measured with other YBCO+ND samples and similar to the best results achieved by YBCO films grown in the same conditions^{*a*} ($T_c = 90.2 \pm 0.4$ K).⁶

Again, the film deposited with the solution containing ND showed an improvement of transport properties in self-field conditions that, as already hypothesized, could be originated from the excellent grain coalescence and film density, which promotes the current percolation path.³



Figure 9. XRD θ -2 θ patterns of partially converted YBCO+ND samples: one sample pyrolyzed at 480 °C and six samples quenched after pyrolysis at different temperatures during the firing treatment. The curve named "830 °C + 30'" indicates a sample treated at 830 °C for 30 min before quenching. The pattern of a film subjected to the whole firing process and labeled as "full firing" is plotted for comparison. Vertical lines show the peak positions of BaF₂ (dashed line), Y₂Cu₂O₅ (dotted line), and CuO (continuous line). The labels of (111), (200), (220) BaF₂ and (004), (005) YBCO peaks are also reported. The asterisk (*) evidences a Y–Ti–O secondary phase due to the solution–substrate interaction.^{36,37} The symbol (\Diamond) marks the STO K_{β} peak.

Nanodiamond Effect on YBCO Nucleation and Growth. The analysis of the XRD pattern of partially converted YBCO samples evidenced that, after the pyrolysis process, the precursor film was composed of Y_2O_3 , CuO, and $Ba_{1-x}Y_xF_{2+x^j}$ (BYF), the latter being a solid solution of YF₃ in BaF₂ with a fluorite crystalline structure (Figure 8). The observed conversion is in agreement with the study performed by Armenio et al.,³⁰ in which a similar low-fluorine propionate solution was pyrolyzed using a comparable thermal treatment.

In Figure 8, XRD θ -2 θ patterns of samples treated at different temperatures are plotted. Increasing the treatment temperature, relevant changes were observed. BYF peak intensity increased up to 750 °C and their position shifted first to lower angles. Yttrium fluoride exhibits solubility in the BaF2 fluorite crystalline structure in a wide range of compositions, x, forming a solid solution $Ba_{1-x}Y_xF_{2+x}$. The increase of the YF₃ concentration in the BaF2 lattice induces a linear elongation of the lattice parameter.³¹ Thus, a shift in the XRD BYF peak positions can be considered a signature of the Y composition variation. At 650 °C, the peak at $2\theta = 28.8^{\circ}$ can be attributed to pure BaF₂, demonstrating the reduction of the Y fraction in the solid solution with increasing temperature. Then, YF₃ conversion to Y-oxyfluorides and Y₂O₃ can be hypothesized in analogy with what was demonstrated by the XPS analyses reported in ref 30. At 750 °C, a second shift was observed at higher angles. This shift was previously attributed to Ba-oxyfluoride, $BaF_{2(1-x)}O_{xy}$ (OF) formation.³² At the same time, evident (00l) reflections of YBCO appeared at 750 °C in agreement with ref 30. However, in ref 30, at 750 °C, the peak intensities of OF (200) and YBCO (005) were comparable, while in the present work, at the same

temperature, a sharp decrease of OF occurred and the OF peaks were negligible in comparison with YBCO peaks. This difference could be ascribed both to precursor solution concentration (more diluted in the present work and corresponding to a thinner film, namely, 0.2 M with respect to 0.4 M used by ref 30) and to oxygen partial pressure used during the crystallization step, in our case lower than that in ref 30, i.e., O_2/N_2 is equal to 4×10^{-4} and 3×10^{-2} , respectively. The effect of oxygen content in the atmosphere of heat treatment has been extensively studied and has significant importance on the process.^{33–35}

Finally, a linear increase in the intensity of the YBCO phase was observed between the nucleation temperature and plateau temperature (830 °C). The YBCO peaks of the fully converted sample are slightly shifted toward higher angles due to the YBCO conversion from the tetragonal to orthorhombic phase occurring during the oxygenation treatment and subsequent to the crystallization step (Figure 1). Interestingly, the Y–Ti–O secondary phase appeared in the sample quenched after 30 min at 830 °C and was evident in the fully processed sample. Its origin is due to the solution–substrate interaction.^{36,37}

In conclusion, considering these results and the literature data,^{30,35,38} these XRD results are consistent with the crystallization of YBCO through the chemical reaction I already proposed for fluorine-based MOD processes by several articles.^{30,35,39–42}

$$2BaF_{2(1-x)}O_{x} + 3CuO + \frac{1}{2}Y_{2}O_{3} + 2(1-x)H_{2}O(g)$$

$$\rightarrow YBa_{2}Cu_{3}O_{6.5} + 4(1-x)HF(g)$$
(I)

A similar study was then performed on the YBCO+ND system. In Figure 9, θ -2 θ XRD spectra evidenced some interesting differences.

The evolution of BYF peaks was comparable to the YBCO film as regards peak shift, at first, to lower angles of up to 650 °C, evidencing the reduction of the Y fraction in the BYF phase. At 650 °C, the spectra of YBCO and YBCO+ND were very similar. By increasing the temperature in the YBCO+ND film, a further shift at higher angles was again revealed, indicative of OF formation. Similarly to the undoped sample, (00/) YBCO reflections emerged. However, the intensity ratio of OF, considering the (111), (200), and (220) peaks and YBCO (005) significantly changed among YBCO and YBCO+ND films. In the latter case, at 750 °C a greater amount of OF was still evident with respect to the YBCO sample.

Even at 795 °C, a higher OF content was detected in relation to the YBCO film, where, on the contrary, OF peaks were negligible. The presence of ND seems to slow down reaction I to the point that after a 30 min plateau at 830 °C, OF in the YBCO +ND sample was still present. The evolution of integrated peaks, normalized to the total spectrum area, confirms this outcome. The integrated areas of OF peaks, considering the sum of (111), (200), and (220) peaks and the (005) YBCO peak, indicated as I^{OF} and I^{YBCO} , respectively, detected in precursor films after quenching are reported in Figure 10a,b and Table 1. The comparison between YBCO and YBCO+ND film pairs evidenced how markedly ND affected reaction I in the temperature range of 750–830 °C. The integrated area fractions of OF and YBCO peaks were also calculated according to $\frac{I^{OF}}{(I^{OF} + I^{YBCO})}$ and $\frac{I^{YBCO}}{(I^{OF} + I^{YBCO})}$, respectively (Figure 10c and Table

1). The intensities of the XRD spectra shown in Figures 8 and 9 provide qualitative insights into the evolution of the film composition during the heat treatment. To gain more quantitative information on the kinetics of film formation, we performed a simple comparative analysis of the data of Table 1, where the quenched samples are representative of the composition of the film at the time of quenching (i.e., at a temperature just before quenching).

The XRD intensity is proportional to the square of the number of unit cells of the compound, in the sampled volume, through the structure factor. It follows that the relative variation of intensity, in time interval $\Delta t = \Delta T/\phi$ (with ϕ = constant heating rate), is linked to the relative variation of the amount of the phase: $\frac{\Delta I}{I} = \frac{\Delta (N^2)}{N^2}$, that is the rate of variation of the relative amount of compounds: $\frac{(\Delta I/I)}{\Delta t} = 2\frac{(\Delta N/N)}{\Delta t}$. In the differential form, this relation implies $\frac{d \ln I}{dT} = 2\frac{d \ln N}{dT}$, at constant ϕ .

A rough computation of the kinetics of the relative amount of OF and YBCO phases can be attempted by considering OF intensity peaks due to a compound (i.e., assign a single structure factor to the peaks) and similarly for YBCO. To this end, the data points in Table 1 were fitted by a continuous (and derivable) function. The results of this approach are shown in Figure 11 for the YBCO e YBCO+ND data. The comparison between the derivatives $\frac{d \ln I}{dT}$ (i.e., $2\frac{d \ln N}{dT}$) of YBCO and OF in both YBCO and YBCO+ND is displayed in Figure 12a,b. The curves in Figure 12a indicate that at high temperatures (T > 730 °C), the relative variation of the amount of YBCO. The relative variation of the amount of YBCO.



Figure 10. Temperature dependence of the XRD integrated intensity of (a) the sum of (111), (200), and (220) OF peaks ($I^{\rm OF}$) and (b) (005) YBCO peak ($I^{\rm YBCO}$) detected in YBCO (black squares) and YBCO +ND (red circles) precursor films after quenching during the conversion thermal treatment. Each peak was normalized to the total spectrum integral. (c) The OF (open and full blue squares) and YBCO (open and full orange circles) peak integrated area fractions, calculated according to $\frac{I^{\rm OF}}{(I^{\rm OF}+I^{\rm YBCO})}$ and $\frac{I^{\rm YBCO}}{(I^{\rm OF}+I^{\rm YBCO})}$, are reported for YBCO (open symbols) and YBCO+ND (full symbols), respectively. The error bars are, in most cases, smaller than the size of the symbols. The labels "830 °C+30' " and "full firing" refer to data obtained for the sample treated at 830 °C for 30 min before quenching and the fully converted film, respectively. The heating rate, up to 830 °C, was set equal to 30 °C min⁻¹ (Figure 1).

variation of the amount of OF in YBCO+ND is greater than that of OF in YBCO in the whole temperature domain (Figure 12b).

Table 1. Temperature Dependence of the XRD Normalized Integrated Area (Upper Panel) and Integrated Area Fraction (Lower Panel) of the Sum of (111), (200), and (220) OF (I^{OF}) and (005) YBCO Peaks (I^{YBCO}) Detected in YBCO and YBCO+ND Precursor Films after Quenching during the Conversion Thermal Treatment^{*a*}

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	normalized integrated area ^b			
thermal treatment	$I^{\rm OF}$		I ^{YBCO}	
	УВСО	YBCO+ND	УВСО	YBCO+ND
quench @650 °C	0.018 ± 0.002	0.022 ± 0.004	0.003 ± 0.001	
quench @750 °C	0.087 ± 0.003	0.195 ± 0.003	0.294 ± 0.007	0.139 ± 0.001
quench @795 °C	0.004 ± 0.001	0.270 ± 0.006	0.670 ± 0.003	0.308 ± 0.006
quench @830 °C		0.031 ± 0.001	0.690 ± 0.002	$0.648 \pm < 0.001$
quench @830 °C+30′		$0.002 \pm < 0.001$	0.684 ± 0.002	$0.719 \pm < 0.001$
full firing			0.629 ± 0.003	0.736 ± 0.001
	integrated area fraction ^b			
thermal treatment	$\frac{1^{\text{OF}}}{(I^{\text{OF}} + I^{\text{YBCO}})}$		$\frac{I^{\text{YBCO}}}{(I^{\text{OF}} + I^{\text{YBCO}})}$	
	YBCO	YBCO+ND	УВСО	YBCO+ND
quench @650 °C	0.821 ± 0.213	1.000 ± 0.359	0.131 ± 0.058	
quench @750 °C	0.228 ± 0.013	0.583 ± 0.016	0.772 ± 0.040	0.416 ± 0.008
quench @795 °C	0.005 ± 0.001	0.467 ± 0.019	0.995 ± 0.011	0.533 ± 0.023
quench @830 °C		0.046 ± 0.002	1.000 ± 0.005	0.954 ± 0.002
quench @830 °C+30'		$0.002 \pm < 0.001$	1.000 ± 0.007	0.998 ± 0.001
full firing			1.000 ± 0.008	1.000 ± 0.004

^{*a*}Each peak was normalized to the total spectrum integral. The integrated area fractions of OF and YBCO peaks are calculated according to $\frac{I^{\text{OF}}}{(I^{\text{OF}}+I^{\text{YBCO}})}$ and $\frac{I^{\text{YBCO}}}{(I^{\text{OF}}+I^{\text{YBCO}})}$, respectively, and reported for YBCO and YBCO+ND, respectively. The labels "830 °C+30′" and "full firing" refer to data obtained for the sample treated at 830 °C for 30 min before quenching and the fully converted film, respectively. ^{*b*}The integrated area of each

data obtained for the sample treated at 830 °C for 30 min before quenching and the fully converted film, respectively. "The integrated area of each peak was obtained from three different area measurements. The errors reported in the table were calculated according to the propagation of uncertainty formulas.

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Figure 11. Experimental data of Table 1 fitted by continuous functions. Symbols show the temperature dependence of the XRD normalized integrated area of (005) YBCO peaks ($I^{\rm YBCO}$) detected in YBCO (black square) and YBCO+ND (red circle) precursor films after quenching during the conversion thermal treatment. Each peak was normalized to the total spectrum integral. The fit is represented by black continuous and red dashed curves for YBCO and YBCO+ND, respectively.

This analysis, although based on few data points, gives more quantitative support to the evolution of the film composition derived in Figure 10. In particular, the kinetics of OF conversion into YBCO is slowed down in YBCO+ND compared to that in the YBCO sample, and this justifies a more extended reaction for YBCO formation at T > 730 °C. A crude interpretation of these behaviors can be proposed as follows.

Let us consider the first-order kinetics $\frac{dN}{dT} = K(T)N$ and $\frac{dN}{dT} = -K'(T)N$ for the formation and consumption of a compound with *K* and *K'* effective rate constants (positive definite), respectively. Accordingly, $\frac{d \ln N}{dT}$ is equal to either K(T) or -K'(T). On this basis, the plots above indicate that the rate constant for YBCO formation in YBCO+ND is greater than that for YBCO formation in YBCO for T > 730 °C. As far as OF is concerned, the plot in Figure 12b shows that for T > 730 °C, OF is consumed in the YBCO sample, while in YBCO+ND, it is still under formation. It follows that the kinetics of OF production/ conversion into YBCO is slowed down in YBCO+ND compared to that in the YBCO sample, and this entails a more extended reaction for the YBCO formation in the temperature domain T > 730 °C.

The trend of the different OF growth directions has been also evaluated and does not change if ND is present. As can be seen in Figure 13, ND slows down the decomposition of the three phases in the same way and the integrated area of the (111) phase is the most intense one in both films.

Moreover, the signal of crystalline CuO was detected in the range of 750–795 °C in the YBCO+ND sample, while it was slightly visible only at 750 °C in the pure YBCO film. The more gradual CuO consumption could support the idea of a slower YBCO crystallization process.

Finally, the Y–Ti–O secondary phase was revealed in the samples quenched at 830 °C and fully converted (Figure 9). No trend of peak intensity could emerge, confirming that the formation of this phase randomly occurs and depends on substrate variability.^{36,37}



Figure 12. Comparison between the derivatives $\frac{d \ln N}{dT}$ (i.e., $\frac{1}{2} \frac{d \ln I}{dT}$) of YBCO (a) and OF (b) in both YBCO (black continuous curve) and YBCO+ND (red dashed curve) samples.



Figure 13. Temperature dependence of the XRD integrated intensity of (111), (200), and (220) OF (I^{OF}) detected in YBCO (a) and YBCO+ND (b) precursor films after quenching during the conversion thermal treatment. Each peak was normalized to the total spectrum integral. The error bars are, in most cases, smaller than the symbol size. The labels "830 °C+30′ " and "full firing" refer to data obtained for the sample treated at 830 °C for 30 min before quenching and the fully converted film, respectively.

DISCUSSION

Although the role played by ND is not fully discerned, some hypotheses can be formulated. In the literature, many papers have been devoted to nanocarbon fluorination and have shown that carbon of the CBN surface can easily react with fluorine to form a strong -C-F bond. Fluorination is considered one of the most effective chemical methods to modify and control the physicochemical properties of carbon materials.⁴³⁻⁴⁹ For example, Liu et al. reported the treatment of ND powder (characterized by a particle size ranging from 3.5 to 6.5 nm) with HF generated in situ.⁴⁶ The authors stated that fluorination took place at a temperature above 150 °C and was easily obtained without any ND pretreatment, i.e., by hydrogenation or oxidation. The reaction was supposed to involve the alreadyexisting surface functionalities, which have been activated by the in situ-generated HF catalyst. The IR spectrum showed that at 150 °C, all of the surface C-H bonds were completely fluorinated. By increasing the temperature to 310 °C, almost all C=O, C=C, and OH groups were removed or transformed. Increasing the fluorination temperature to 410 and 470 °C did not cause any significant changes in the IR spectra of the resulting fluoro-nanodiamond samples. Many other works reported fluorination reactions carried out in similar conditions^{43,44,47,50} that did not substantially differ from our

situation in which F was present in the metal precursor, and HF was one of the reaction products (I) during the thermal treatment. Moreover, the C-F bond is particularly strong as demonstrated by several theoretical and experimental studies.^{43,44,47,51,52} The F-terminated ND surface is more stable and chemically inert than the H-terminated one. Therefore, fluorinated diamond is exceptionally resistant to thermal effects.⁴⁷ In this sense, the work made by Ando et al. on fluorinated diamond powder is worth mentioning.⁴³ Fluorine desorption, carried out using He as the carrier gas, started above 450 °C with distinctive desorption maxima at ~600 and ~1100 °C (see Figure 3 in ref 43). Similarly, Smentkowski and Yates⁵² stated that surface-fluorinated diamond thermally decomposed in vacuum in the range of 900-1500 K, corresponding to approximately 630–1130 °C (Figure 4 in ref 52). However, the fluorine desorption temperature range strongly depends on the considered diamond form (powder, nanopowder, crystal, film) and on the atmosphere.⁴

Actually, in our case, the ND fate was still not completely understood. TEM analyses showed a homogeneous but not relevant C distribution in the film matrix because no traces of ND particles or aggregates appeared. Therefore, ND was probably transformed, but at the moment we ignore the route of ND consumption. However, it is likely promoted by oxygen in



Figure 14. Schematic representation of the YBCO low-fluorine MOD process without and with ND.

the process atmosphere. Indeed, high temperatures are able to induce surface graphitization and subsequent combustion.^{53,54} Anyway, it should be considered that fluorination could be rather straightforward also taking into account other CBNs (CNT, graphene, onion-like structure).⁴⁹ Therefore, during YBCO deposition, ND or its derivatives could interact with fluorine existing in the film matrix through both hydrogen and covalent bonds, the latter replacing its surface H or O atoms (present as C=O or C-OH). This reaction could be catalyzed by the HF produced during YBCO precursor decomposition.⁵⁵ Hence, it should be presumed that strong C–F bond formation occurred and was probably resistant to our thermal treatment. YBCO nucleation was in some way influenced by this side reaction, despite the ND content in the precursor matrix being negligible with respect to the BaF₂ amount. But, as for catalysis, only a small ND amount could be necessary. For example, fluorinated ND could act as a nucleation seed favoring OF coarsening, which would subsequently require a prolonged decomposition time. In other words, ND would have the effect of stabilizing the OF phase by making it kinetically less reactive. Otherwise, it could hamper the evolution of BaF2 toward $BaF_{2(1-x)}O_x$ (with $x \neq 0$). As already evidenced by ref 56, the x value strongly affects the free energy change of reaction I; thus, at 750 °C and $\frac{p_{\rm HF}^2}{p_{\rm Hgo}} > 10^{-8}$, a reduction of the x value corresponds to a critical increase of reaction free energy, $\Delta_r G$, (Figure 2 in ref 56). Conversely, at 800 °C and $\frac{P_{\rm HF}^2}{P_{\rm HyO}} < 10^{-8}$, reaction I is spontaneous in the full x range. In any case, due to the presence of ND, we observed a delay of YBCO nucleation, which occurred at a higher T than usual, when the C-F bond could be more easily broken and/or reaction I could be favored from a thermodynamic point of view.

However, regardless of the reaction mechanism, the excellent morphology of YBCO+ND with improved superconducting properties should derive from the possibility of starting nucleating at higher temperatures, when the best conditions for *c*-axis nucleation occur.⁵⁶ A schematic representation of ND influence on the YBCO deposition process is reported in Figure 14.

Certainly, our hypotheses should be verified by further investigation. But, at this stage, these results could have interesting perspectives. For example, the effect of ND on YBCO nucleation could represent a route to directly reach the ideal temperature window for *c*-axis nucleation as similarly proposed and recently obtained by the "ultrafast transient liquid assisted growth" and "flash heating" procedures.^{9,15,57,58} These approaches used very fast heating rates (up to 80 °C·s⁻¹) to deposit highly *c*-axis YBCO films by quickly crossing the temperature region where undesired phases could nucleate.

CONCLUSIONS

In this paper, the study of the influence of ND on YBCO nucleation mechanisms has been reported. Specifically, in YBCO+ND samples, the chemical reaction responsible for YBCO nucleation was inhibited and occurred at higher temperatures compared to pristine samples. Further investigations will be necessary in order to evaluate the exact ND role. However, a possible scenario was proposed. Anyway, the increased nucleation temperature promoted *c*-axis crystallization, with consequent formation of highly epitaxial films.

As regards ND fate, TEM analyses did not evidence any ND particle in the film matrix. Probably, ND did not survive the used thermal treatment. However, its beneficial effect on YBCO nucleation can be further exploited and the opportunity to use ND in combination with other conventional APCs will be evaluated.

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Author Contributions

The manuscript was written by V.P., A.V., and M.T. All authors revised the final version of the manuscript and approved it. Films were grown and characterized by V.P. except for SEM and TEM investigations carried out by A.V. and A.M., respectively. V.P. and M.T. performed data analysis. G.C. contributed to funding acquisition and project administration. S.O. supervised the activity.

Notes

The authors declare no competing financial interest.

ACKNOWLEDGMENTS

This work was carried out within the framework of the EUROfusion Consortium and received funding from the Euratom programme 2014–2018 and 2019–2020 under grant agreement No. 633053. The views and opinions expressed herein do not necessarily reflect those of the European Commission. TEM analysis was funded by the European Union's Horizon 2020 research and innovation programme under grant agreement No. 823717 – ESTEEM3 (Nano-engineered YBCO Superconducting Tapes for High Field Applications, NESTApp). The authors S.O. and M.T. gratefully acknowledge the financial support from the Department of Chemical Science and Technologies Chemistry, University of Rome Tor Vergata, project ISeeFunND. V.P. thanks M. Pulidori and M. Ferrazzano for graphical abstract realization.

ABBREVIATIONS

ADF-STEM, annular dark-field scanning transmission electron microscopy; APCs, artificial pinning centers; CBNs, carbonbased nanomaterials; CSD, chemical solution deposition; EDX, energy-dispersive X-ray spectroscopy; FWHM, Full width at half-maximum; HAADF-STEM, high-angle annular dark-field scanning transmission electron microscopy; J_c , critical current density; MOD, metal–organic decomposition; ND, nanodiamond; NPs, nanoparticles; OF, BaF_{2(1-x)}O_x; PLD, pulsed laser deposition; *REBCO*, *REBa*₂Cu₃O_{7-x} in which *RE* is Y or rare earth; SEM, scanning electron microscopy; STO, SrTiO₃; T_c , critical temperature; TEM, transmission electron microscopy; YBCO, YBa₂Cu₃O_{7- δ}; XRD, X-ray diffraction

ADDITIONAL NOTE

^{*a*}The mean value is expressed as the mean and standard deviation of results obtained for several samples prepared in the same laboratory and with the same procedure

REFERENCES

(1) Dew-Hughes, D. The Critical Current of Superconductors: An Historical Review. *Low Temp. Phys.* **2001**, *27*, 713–722.

(2) 100 Years of Superconductivity; Rogalla, H.; Kes, P. H., Eds.; CRC Press: Boca Raton, 2012.

(3) Feighan, J. P. F.; Kursumovic, A.; MacManus-Driscoll, J. L. Materials Design for Artificial Pinning Centres in Superconductor PLD Coated Conductors. *Supercond. Sci. Technol.* **2017**, *30*, No. 123001.

(4) Foltyn, S. R.; Civale, L.; MacManus-Driscoll, J. L.; Jia, Q. X.; Maiorov, B.; Wang, H.; Maley, M. Materials Science Challenges for High-Temperature Superconducting Wire. *Nat. Mater.* **2007**, *6*, 631–642.

(5) Matsumoto, K.; Mele, P. Artificial Pinning Center Technology to Enhance Vortex Pinning in YBCO Coated Conductors. *Supercond. Sci. Technol.* **2010**, *23*, No. 014001.

(6) Pinto, V.; Vannozzi, A.; Angrisani Armenio, A.; Rizzo, F.; Masi, A.; Santoni, A.; Meledin, A.; Ferrarese, F. M.; Orlanducci, S.; Celentano, G. Chemical Solution Deposition of YBCO Films with Gd Excess. *Coatings* **2020**, *10*, 860.

(7) Erbe, M.; Hänisch, J.; Hühne, R.; Freudenberg, T.; Kirchner, A.; Molina-Luna, L.; Damm, C.; Van Tendeloo, G.; Kaskel, S.; Schultz, L.; Holzapfel, B. BaHfO₃ Artificial Pinning Centres in TFA-MOD-Derived YBCO and GdBCO Thin Films. *Supercond. Sci. Technol.* **2015**, *28*, No. 114002.

(8) Gutiérrez, J.; Llordés, A.; Gázquez, J.; Gibert, M.; Romà, N.; Ricart, S.; Pomar, A.; Sandiumenge, F.; Mestres, N.; Puig, T.; Obradors, X. Strong Isotropic Flux Pinning in Solution-Derived YBa 2 Cu 3 O 7–x Nanocomposite Superconductor Films. *Nat. Mater.* **2007**, *6*, 367–373.

(9) Soler, L.; Jareño, J.; Banchewski, J.; Rasi, S.; Chamorro, N.; Guzman, R.; Yáñez, R.; Mocuta, C.; Ricart, S.; Farjas, J.; Roura-Grabulosa, P.; Obradors, X.; Puig, T. Ultrafast Transient Liquid Assisted Growth of High Current Density Superconducting Films. *Nat. Commun.* **2020**, *11*, No. 344.

(10) De Keukeleere, K.; Cayado, P.; Meledin, A.; Vallès, F.; De Roo, J.; Rijckaert, H.; Pollefeyt, G.; Bruneel, E.; Palau, A.; Coll, M.; Ricart, S.; Van Tendeloo, G.; Puig, T.; Obradors, X.; Van Driessche, I. Superconducting YBa $_2$ Cu $_3$ O $_{7-\delta}$ Nanocomposites Using Preformed ZrO $_2$ Nanocrystals: Growth Mechanisms and Vortex Pinning Properties. *Adv. Electron. Mater.* **2016**, *2*, No. 1600161.

(11) Díez-Sierra, J.; López-Domínguez, P.; Rijckaert, H.; Rikel, M.; Hänisch, J.; Khan, M. Z.; Falter, M.; Bennewitz, J.; Huhtinen, H.; Schäfer, S.; Müller, R.; Schunk, S. A.; Paturi, P.; Bäcker, M.; De Buysser, K.; Van Driessche, I. High Critical Current Density and Enhanced Pinning in Superconducting Films of YBa $_2$ Cu $_3$ O $_{7-\delta}$ Nanocomposites with Embedded BaZrO $_3$, BaHfO $_3$, BaTiO $_3$, and SrZrO $_3$ Nanocrystals. *ACS Appl. Nano Mater.* **2020**, 3, 5542–5553.

(12) Pinto, V.; Augieri, A.; Vannozzi, A.; Fabbri, F.; Celentano, G.; Domenici, F.; Orlanducci, S. Nanodiamond: A New Tool for Artificial Pinning Center Introduction in YBCO Films Obtained Through Chemical Solution Deposition. *IEEE Trans. Appl. Supercond.* **2018**, *28*, 1–4.

(13) Pinto, V.; Vannozzi, A.; Angrisani Armenio, A.; Celentano, G.; De Angelis, M.; Rizzo, F.; Carcione, R.; Domenici, F.; Palmieri, D.; Politi, S.; Tomellini, M.; Orlanducci, S. Nanodiamond Addition to Chemical Solution Deposited YBa2Cu3O7- δ Film: Effect on Structural and Superconducting Properties. *Thin Solid Films* **2020**, *693*, No. 137696.

(14) Coll, M.; Guzman, R.; Garcés, P.; Gazquez, J.; Rouco, V.; Palau, A.; Ye, S.; Magen, C.; Suo, H.; Castro, H.; Puig, T.; Obradors, X. Size-Controlled Spontaneously Segregated Ba $_2$ YTaO $_6$ Nanoparticles in YBa $_2$ Cu $_3$ O $_7$ Nanocomposites Obtained by Chemical Solution Deposition. *Supercond. Sci. Technol.* **2014**, *27*, No. 044008.

(15) Li, Z.; Coll, M.; Mundet, B.; Chamorro, N.; Vallès, F.; Palau, A.; Gazquez, J.; Ricart, S.; Puig, T.; Obradors, X. Control of Nanostructure and Pinning Properties in Solution Deposited YBa2Cu3O7–x Nanocomposites with Preformed Perovskite Nanoparticles. *Sci. Rep.* **2019**, *9*, No. 5828.

(16) Obradors, X.; Puig, T.; Li, Z.; Pop, C.; Mundet, B.; Chamorro, N.; Vallés, F.; Coll, M.; Ricart, S.; Vallejo, B.; Pino, F.; Palau, A.; Gázquez, J.; Ros, J.; Usoskin, A. Epitaxial YBa $_2$ Cu $_3$ O $_{7-x}$ Nanocomposite Films and Coated Conductors from Ba M O $_3$ (M = Zr, Hf) Colloidal Solutions. *Supercond. Sci. Technol.* **2018**, 31, No. 044001.

(17) Rijckaert, H.; Hänisch, J.; Pollefeyt, G.; Bäcker, M.; Driessche, I. V. Influence of Ba2+ Consumption and Intermediate Dwelling during Processing of YBa2Cu3O7 Nanocomposite Films. *J. Am. Ceram. Soc.* **2019**, *102*, 3870–3878.

(18) Rijckaert, H.; De Roo, J.; Van Zele, M.; Banerjee, S.; Huhtinen, H.; Paturi, P.; Bennewitz, J.; Billinge, S. J. L.; Bäcker, M.; De Buysser, K.; Van Driessche, I. Pair Distribution Function Analysis of ZrO2 Nanocrystals and Insights in the Formation of ZrO2-YBa2Cu3O7 Nanocomposites. *Materials* **2018**, *11*, 1066.

(19) Rijckaert, H.; Pollefeyt, G.; Sieger, M.; Hänisch, J.; Bennewitz, J.; De Keukeleere, K.; De Roo, J.; Hühne, R.; Bäcker, M.; Paturi, P.; Huhtinen, H.; Hemgesberg, M.; Van Driessche, I. Optimizing Nanocomposites through Nanocrystal Surface Chemistry: Superconducting YBa $_2$ Cu $_3$ O $_7$ Thin Films via Low-Fluorine Metal Organic Deposition and Preformed Metal Oxide Nanocrystals. *Chem. Mater.* **2017**, *29*, 6104–6113.

(20) Sun, M. J.; Liu, W. Q.; He, K.; Liu, Z. Y.; Chen, S. G.; Cai, C. B. Orientation Behavior and Mechanism of Ag-Doped GdBa2Cu3O7-δ Superconducting Thin Films Derived by Metal Organic Deposition. *J. Supercond. Novel Magn.* **2018**, *31*, 3159–3162.

(21) Obradors, X.; Martínez-Julián, F.; Zalamova, K.; Vlad, V. R.; Pomar, A.; Palau, A.; Llordés, A.; Chen, H.; Coll, M.; Ricart, S.; Mestres, N.; Granados, X.; Puig, T.; Rikel, M. Nucleation and Mesostrain Influence on Percolating Critical Currents of Solution Derived YBa2Cu3O7 Superconducting Thin Films. *Phys. C* **2012**, *482*, 58–67.

(22) Feng, F.; Huang, R.; Qu, T.; Zhu, Y.; Lu, H.; Zhang, X.; Xiao, S.; Hou, Z.; Zeng, P.; Han, Z. Property Improvement of 600-Nm-Thick YBCO Superconducting Films Fabricated Using a Pb-Modified MOD Method. *IEEE Trans. Appl. Supercond.* **2016**, *26*, 1–5.

(23) Tang, X.; Zhao, Y.; Wu, W.; Andersen, N. H.; Grivel, J.-C. High-Jc YBa2Cu3O7–x-Ag Superconducting Thin Films Synthesized through a Fluorine-Free MOD Method. *J. Eur. Ceram. Soc.* **2015**, *35*, 1761–1769.

(24) McIntyre, P. C.; Cima, M. J.; Ng, M. F.; Chiu, R. C.; Rhine, W. E. Texture Development in Ba2YCu307–x Films from Trifluoroacetate Precursors. *J. Mater. Res.* **1990**, *5*, 2771–2779.

(25) Kovács, A.; Schierholz, R.; Tillmann, K. FEI Titan G2 80-200 CREWLEY. J. Large-Scale Res. Facil. **2016**, *2*, 43.

(26) Heggen, M.; Luysberg, M.; Tillmann, K. FEI Titan 80-300 STEM. J. Large-Scale Res. Facil. 2016, 2, 42.

(27) Meledin, A.; Turner, S.; Cayado, P.; Mundet, B.; Solano, E.; Ricart, S.; Ros, J.; Puig, T.; Obradors, X.; Van Tendeloo, G. Unique Nanostructural Features in Fe, Mn-Doped YBCO Thin Films. *Supercond. Sci. Technol.* **2016**, *29*, No. 125009.

(28) Palau, A.; Vallès, F.; Rouco, V.; Coll, M.; Li, Z.; Pop, C.; Mundet, B.; Gàzquez, J.; Guzman, R.; Gutierrez, J.; Obradors, X.; Puig, T. Disentangling Vortex Pinning Landscape in Chemical Solution Deposited Superconducting YBa2Cu3O7-Xfilms and Nanocomposites. *Supercond. Sci. Technol.* **2018**, *31*, No. 034004.

(29) Piperno, L.; Angrisani Armenio, A.; Vannozzi, A.; Mancini, A.; Rizzo, F.; Augieri, A.; Pinto, V.; Rufoloni, A.; Mos, R. B.; Ciontea, L.; Petrisor, T.; Petrisor, T.; Sotgiu, G.; Celentano, G. Polymer-Assisted Surface Decoration for Critical Current Enhancement in YBa2-Cu3O7-x Films. *Appl. Surf. Sci.* **2019**, *484*, 237–244.

(30) Armenio, A. A.; Augieri, A.; Ciontea, L.; Contini, G.; Davoli, I.; Giovannantonio, M. D.; Galluzzi, V.; Mancini, A.; Rufoloni, A.; Petrisor, T.; Vannozzi, A.; Celentano, G. Structural and Chemical Evolution of Propionate Based Metal–Organic Precursors for Superconducting YBa $_2$ Cu $_3$ O $_{7-\delta}$ Epitaxial Film Growth. Supercond. Sci. Technol. 2011, 24, No. 115008.

(31) Sobolev, B. P.; Tkachenko, N. L. Phase Diagrams Of BaF,-(Y, Ln)Fs Systems. J. Less-Common Met. **1982**, 85, 155–170.

(32) Gàzquez, J.; Sandiumenge, F.; Coll, M.; Pomar, A.; Mestres, N.; Puig, T.; Obradors, X.; Kihn, Y.; Casanove, M. J.; Ballesteros, C. Precursor Evolution and Nucleation Mechanism of YBa $_2$ Cu $_3$ O $_x$ Films by TFA Metal–Organic Decomposition. *Chem. Mater.* **2006**, *18*, 6211–6219.

(33) Chen, H.; Zalamova, K.; Pomar, A.; Granados, X.; Puig, T.; Obradors, X. Nucleation and Growth Rate Influence on Microstructure and Critical Currents of TFA-YBa ₂ Cu ₃ O ₇ under Low-Pressure Conditions. *J. Mater. Res.* **2010**, *25*, 2371–2379.

(34) Feenstra, R.; Lindemer, T. B.; Budai, J. D.; Galloway, M. D. Effect of Oxygen Pressure on the Synthesis of YBa $_2$ Cu $_3$ O $_{7-x}$ Thin Films by Post-deposition Annealing. *J. Appl. Phys.* **1991**, *69*, 6569–6585.

(35) Obradors, X.; Puig, T.; Ricart, S.; Coll, M.; Gazquez, J.; Palau, A.; Granados, X. Growth, Nanostructure and Vortex Pinning in Superconducting YBa $_2$ Cu $_3$ O $_7$ Thin Films Based on Trifluoroacetate Solutions. *Supercond. Sci. Technol.* **2012**, *25*, No. 123001.

(36) Piperno, L.; Vannozzi, A.; Pinto, V.; Angrisani Armenio, A.; Rondino, F.; Santoni, A.; Mancini, A.; Rufoloni, A.; Augieri, A.; Tortora, L.; Sotgiu, G.; Celentano, G. Interaction between Untreated SrTiO3 Substrates and Solution-Derived YBa2Cu3O7- δ Films. *Appl. Surf. Sci.* **2020**, 528, No. 146402.

(37) Santoni, A.; Rondino, F.; Piperno, L.; Armenio Angrisani, A.; Pinto, V.; Mancini, A.; Augieri, A.; Frolova, A.; Rufoloni, A.; Vannozzi, A.; Pompeo, N.; Sotgiu, G.; Celentano, G. Zirconium Distribution in Solution-Derived BaZrO3 - YBa2Cu3O7- δ Epitaxial Thin Films Studied by X-Ray Photoelectron Spectroscopy. *Thin Solid Films* **2019**, 669, 531–536.

(38) Konya, K.; Ootaguro, K.; Nishiyama, T.; Teranishi, R.; Kiss, T.; Yamada, K.; Kaneko, K.; Yoshizumi, M.; Izumi, T. Effect of Holding Temperature on Microstructures and Jc Properties of YBa2Cu3O7–X Films Fabricated by TFA-MOD Method. *Phys. C* **2013**, *494*, 144–147.

(39) Wu, L.; Zhu, Y.; Solovyov, V. F.; Wiesmann, H. J.; Moodenbaugh, A. R.; Sabatini, R. L.; Suenaga, M. Nucleation and Growth of YBa $_2$ Cu $_3$ O $_x$ on SrTiO $_3$ and CeO $_2$ by a BaF $_2$ Postdeposition Reaction Process. *J. Mater. Res.* **2001**, *16*, 2869–2884.

(40) Castaño, O.; Piñol, S. Kinetics Study of YBCO Thin Film Epitaxic Growth on LAO(100) Single Crystals by the TFA-MOD Method. *Supercond. Sci. Technol.* **2004**, *17*, 1415–1419.

(41) Bian, W.; Chen, Y.; Huang, W.; Zhao, G.; Nishii, J.; Kaiju, H.; Fujioka, M.; Li, L.; Li, N.; Yan, F. Effect of F/Ba Ratio of Precursor Solution on the Properties of Solution-Processed YBCO Superconducting Films. *Ceram. Int.* **2017**, *43*, 8433–8439.

(42) Solovyov, V. F.; Wiesmann, H. J.; Suenaga, M. Nucleation of YBa $_2$ Cu $_3$ O $_{7-x}$ on Buffered Metallic Substrates in Thick Precursor Films Made by the BaF $_2$ Process. *Supercond. Sci. Technol.* **2005**, *18*, 239–248.

(43) Ando, T.; Yamamoto, K.; Matsuzawa, M.; Takamatsu, Y.; Kawasaki, S.; Okino, F.; Touhara, H.; Kamo, M.; Sato, Y. Direct Interaction of Elemental Fluorine with Diamond Surfaces. *Diamond Relat. Mater.* **1996**, *5*, 1021–1025.

(44) Freedman, A. Halogenation of Diamond (100) and (111) Surfaces by Atomic Beams. J. Appl. Phys. **1994**, 75, 3112–3120.

(45) Freedman, A.; Stinespring, C. D. Fluorination of Diamond (100) by Atomic and Molecular Beams. *Appl. Phys. Lett.* **1990**, *57*, 1194–1196.

(46) Liu, Y.; Gu, Z.; Margrave, J. L.; Khabashesku, V. N. Functionalization of Nanoscale Diamond Powder: Fluoro-, Alkyl-, Amino-, and Amino Acid-Nanodiamond Derivatives. *Chem. Mater.* **2004**, *16*, 3924–3930.

(47) Romanov, N. M.; Osipov, V. Y.; Takai, K.; Touhara, H.; Hattori, Y. Infrared Spectroscopic Study to Determine Thermal Resistance of the Functionalized Surface of a Detonation Nanodiamond. *J. Opt. Technol.* **2017**, *84*, 654–657.

(48) Schleger, P.; Hardy, W. N.; Casalta, H. Model for the High-Temperature Oxygen-Ordering Thermodynamics in YBa 2 Cu 3 O 6 + X : Inclusion of Electron Spin and Charge Degrees of Freedom. *Phys. Rev. B* **1994**, *49*, 514–523.

(49) Touhara, H.; Okino, F. Property Control of Carbon Materials by Fluorination. *Carbon* **2000**, *38*, 241–267.

(50) Liu, Y.; Khabashesku, V. N.; Halas, N. J. Fluorinated Nanodiamond as a Wet Chemistry Precursor for Diamond Coatings Covalently Bonded to Glass Surface. J. Am. Chem. Soc. 2005, 127, 3712–3713.

(51) Sen, F. G.; Qi, Y.; Alpas, A. T. Surface Stability and Electronic Structure of Hydrogen- and Fluorine-Terminated Diamond Surfaces: A First-Principles Investigation. *J. Mater. Res.* **2009**, *24*, 2461–2470.

(52) Smentkowski, V. S.; Yates, J. T. Fluorination of Diamond Surfaces by Irradiation of Perfluorinated Alkyl Iodides. *Science* **1996**, 271, 193–195.

(53) Krueger, A.; Lang, D. Functionality Is Key: Recent Progress in the Surface Modification of Nanodiamond. *Adv. Funct. Mater.* **2012**, *22*, 890–906.

(54) Reina, G.; Zhao, L.; Bianco, A.; Komatsu, N. Chemical Functionalization of Nanodiamonds: Opportunities and Challenges Ahead. *Angew. Chem., Int. Ed.* **2019**, *58*, 17918–17929.

(55) Yoshizumi, M.; Wesolowski, D.; Cima, M. J. Determination of HF Partial Pressure during Ex Situ Conversion of YBCO Precursors. *Phys. C* 2005, 423, 75–82.

(56) Pinto, V.; Celentano, G.; Tomellini, M. Heterogeneous Nucleation of YBCO via Fluorine Based MOD Process: Thermodynamic and Kinetic Approach. *Supercond. Sci. Technol.* **2020**, 33, No. 115006.

(57) Li, Z.; Coll, M.; Mundet, B.; Palau, A.; Puig, T.; Obradors, X. Accelerated Growth by Flash Heating of High Critical Current Trifluoroacetate Solution Derived Epitaxial Superconducting YBa $_2$ Cu $_3$ O $_7$ Films. J. Mater. Chem. C **2019**, 7, 4748–4759.

(58) Rasi, S.; Queraltó, A.; Banchewski, J.; Saltarelli, L.; Garcia, D.; Pacheco, A.; Gupta, K.; Kethamkuzhi, A.; Soler, L.; Jareño, J.; Ricart, S.; Farjas, J.; Roura-Grabulosa, P.; Mocuta, C.; Obradors, X.; Puig, T. Kinetic Control of Ultrafast Transient Liquid Assisted Growth of Solution-Derived YBa $_2$ Cu $_3$ O $_7$ -x Superconducting Films. *Adv. Sci.* **2022**, *9*, No. 2203834.